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SPECIFICATION FOR TFT MODULE

MODULE NO.: AVD-TT70WV-NN-002-S

CUSTOMER NO.:

Rev No.: A

AVD	PREPARED BY	CHECKED BY	APPROVED BY
SIGNATURE	叶影中	A July	Nova Liu
DATE	2023.08.30	2023.08.30	2023.08.30

	SIGNATURE	DATE
CUSTOMER APPROVAL		

Notes:

- 1. Please contact AVD before assigning your product based on this module specification.
- 2. To improve the quality of product, and this product specification is subject to change without any notice.



REVISION RECORD

Rev No.	Rev date	Contents	Remarks
0	2019-07-11	First release	Preliminary
Α	2023-08-30	Update	



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1. GENERAL INFORMATION

No.	Item	Contents	Unit
1	LCD size	7.0 inch (Diagonal)	/
2	Display mode	TN/Normally white/Transmissive	/
3	Viewing direction(eye)	12 O'clock	1
4	Gray scale inversion direction	6 O'clock	1
5	Resolution(H*V)	800 *480 Pixels	/
6	Module size (L*W*H)	164.90*100.00*3.50	mm
7	Active area (L*W)	153.84*85.632	mm
8	Pixel pitch (L*W)	0.1923*0.1784	mm
9	Interface type	RGB 24bit interface	/
10	Color Depth	16.7M	/
11	Module power consumption	1.126(Approx)	W
12	Back light type	LED	1
13	Driver IC	EK79716BD4+EK73202AB2 OR COMPATIBLE	/
14	Weight	115.0(Approx)	g

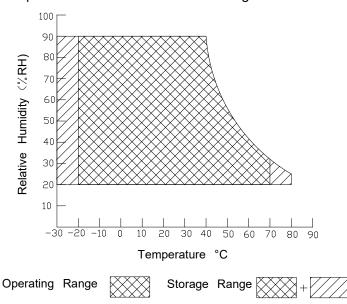
2. ABSOLUTE MAXIMUM RATINGS

Item	Symbol	Min.	Max.	Unit	Note
Power supply input voltage for TFT	VDD	-0.3	5.0	V	
Backlight current (normal temp.)	ILED	-	150	mA	
Operation temperature	Тор	-20	+70	°C	Note1
Storage temperature	Tst	-30	+80	°C	Note1
Humidity	RH	-	90%	RH	Note1

Note1:

1). The relative humidity and temperature range are as below sketch, 90%RH Max.

2). The maximum wet bulb temperature $\leq 40^{\circ}$ C and without dewing.





3. ELECTRICAL CHARACTERISTICS

DC CHARACTERISTICS(at Ta=25°C)

Item	Symbol	Min.	Тур.	Max.	Unit	Note
Power supply input voltage	VDD	3.0	3.3	3.6	V	
I/O logic voltage	VDDIO	-	-	-	V	
Input voltage 'H' level	VIH	0.7VDDIO	-	VDDIO	V	
Input voltage 'L' level	VIL	VSS	-	0.3VDDIO	V	
Power supply current	IVDD	-	14	-	mA	
TFT gate on voltage	VGH	17.0	18.0	19.0	V	
TFT gate off voltage	VGL	-8.8	-7.8	-6.8	٧	
Analog power supply voltage	AVDD	-	10.13	-	V	
Differential input common mode voltage	Vcom	~2.8	~3.8	~4.8	V	Note1

Note1 : The value is just the reference value. The customer can optimize the setting value by the different D-IC Vcom must be adjusted to optimize display quality, as Crosstalk and Contrast Ratio etc..

4. BACKLIGHT CHARACTERISTICS

(at Ta=25°C,RH=60%)

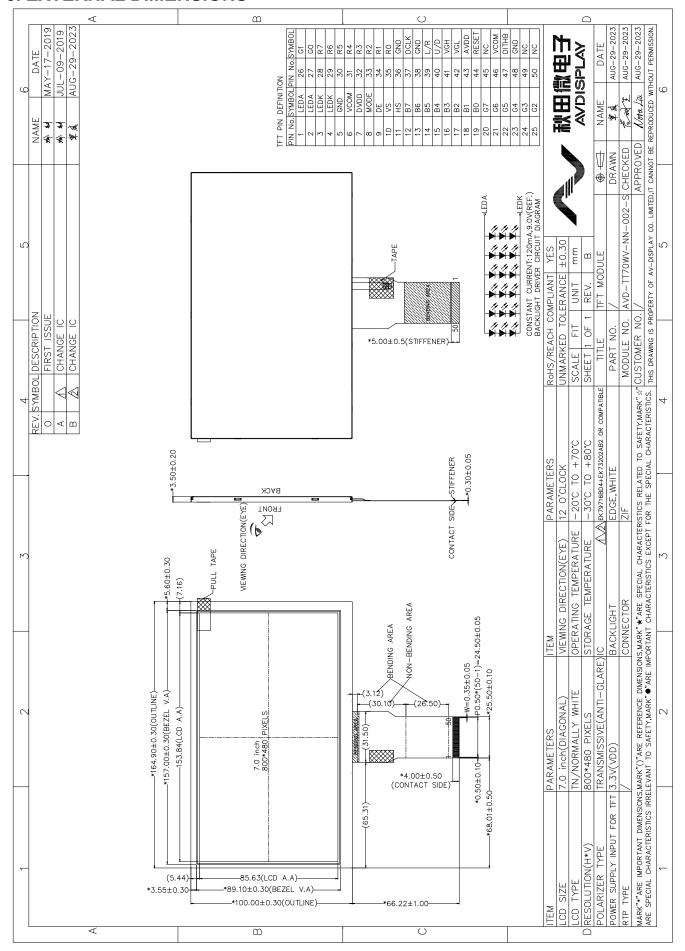
Item	Symbol	Min.	Тур.	Max.	Unit	Note
LED forward voltage	VF	-	9.0	9.6	V	IF=20*6mA
LED forward current	IF	-	120	-	mA	
LED power consumption	PLED	-	1.08	-	W	Note1
Number of LED	-		18		PCS	
Connection mode	-	3 in series 6 in parallel			1	
LED life-time	-	20000	-	-	Hrs	Note2

Note1 : Calculator value for reference : IF*VF = PLED

Note2: The LED life-time define as the estimated time to 50% degradation of initial brightness at Ta=25°C and IF =120mA. The LED lifetime could be decreased if operating IF is larger than 120mA.



5. EXTERNAL DIMENSIONS





6. ELECTRO-OPTICAL CHARACTERISTICS

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	Remark	Note
Response time	Tr+ Tf		-	30	60	ms	FIG.1	Note 1
Contrast ratio	Cr	-	-	500	-	-	FIG.2	Note 2
Surface luminance	Lv	θ=0°	200	280	-	cd/m ²	FIG.2	Note 3
Luminance uniformity	Yu	θ=0°	70	80	-	%	FIG.2	Note 4
NTSC	-	θ=0°	-	50	-	%	FIG.2	Note 5
		∅=90°	60	70	-	deg	FIG.3	Note 6
Viouing angle	θ	∅=270°	40	50	-	deg	FIG.3	
Viewing angle		∅=0°	60	70	-	deg	FIG.3	
		∅=180°	60	70	-	deg	FIG.3	
	Red x			0.57		-		
	Red y			0.33		-		Note 5
	Green x			0.35		-		
CIE (x,y)	Green y	θ=0° ∅=0°	Тур	0.60	Тур	-	FIG.2	
chromaticity	Blue x	 Ta=25°C	-0.04	0.16	+0.04	-	CIE1931	
	Blue y	14 20 0		0.11		-		
	White x			0.31		-		
	White y			0.34		-		

Note1. Definition of response time

The response time is defined as the LCD optical switching time interval between "White" state and "Black"state. Rise time (T_{ON}) is the time between photo detector output intensity changed from 90% to 10%. And fall time (T_{OFF}) is the time between photo detector output intensity changed from 10% to 90%. For additional information see FIG1.

Note2.Definition of contrast ratio

Contrast ratio(Cr) is defined mathematically by the following formula.

For more information see FIG.2.

Contrast ratio= Luminance measured when LCD on the "White" state

Luminance measured when LCD on the "Black" state

Measured at the center area of the LCD

Note3.Definition of surface luminance

Surface luminance is the luminance with all pixels displaying white.

For more information see FIG.2.

Lv = Average Surface Luminance with all white pixels(P1,P2,P3,Pn)

Note4. Definition of luminance uniformity

The luminance uniformity in surface luminance is determined by measuring luminance at each test position 1 through n, and then dividing the maximum luminance of n points luminance by minimum luminance of n points luminance. For more information see FIG.2.

Minimum surface luminance with all white pixels (P1,P2,P3,.....,Pn) Maximum surface luminance with all white pixels (P1,P2,P3,.....,Pn)

Note5. Definition of color chromaticity (CIE1931)

CIE (x,y) chromaticity. The x,y value is determined by screen active area center position P5. For more information see FIG.2.

Note6. Definition of viewing angle

Viewing angle is the angle at which the contrast ratio is greater than 10. angles are determined for the horizontal or x axis and the vertical or y axis with respect to the z axis which is normal to the LCD surface. For more information see FIG.3.

For viewing angle and response time testing, the testing data is base on Autronic-Melchers's ConoScope or DMS series Instruments or compatible. For contrast ratio, Surface Luminance, Luminance uniformity and CIE, the testing data is base on TOPCON's BM-5or BM-7 photo detector or compatible.



FIG.1. The definition of response Time

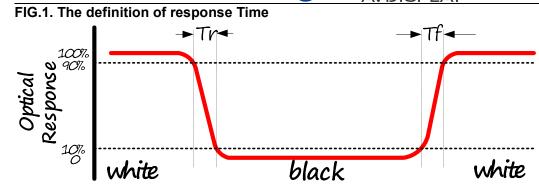


FIG.2. Measuring method for contrast ratio, surface luminance, luminance uniformity, CIE (x,y) chromaticity

H,V: Active area

Light spot size \varnothing =5mm(BM-5) or \varnothing =7.7mm (BM-7)50cm distance or compatible distance from the LCM surface to detector lens.

Test spot position : see Figure a.

measurement instrument: TOPCON's luminance meter BM-5 or BM-7 or compatible, see Figure b.

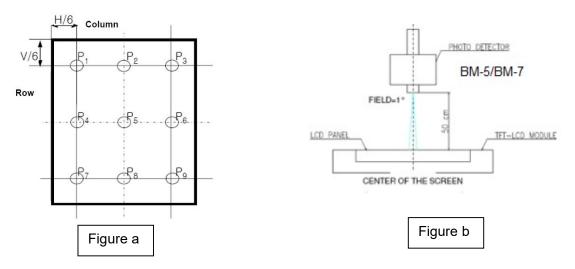
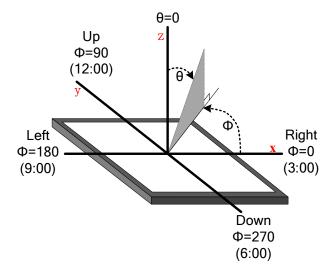


FIG.3. The definition of viewing angle





7. INTERFACE DESCRIPTION

Module Interface description

Interface No.	Name	I/O or connect to	Description
1-2	LEDA	Р	Power for LED backlight(Anode)
3-4	LEDK	Р	Power for LED backlight(Cathode)
5	GND	Р	Power Ground
6	VCOM	I	For external VCOM DC input(Optional)
7	DVDD	Р	Digital Power,
8	MODE	I	DE/SYNC mode select .normally pull high MODE="1"DE mode MODE="0"SYNC mode
9	DE	I	Data Enable signal ;normally pull low
10	VS	I	Vertical sync input.Negative polarity
11	HS	I	Horizontal sync input.Negative polarity
12-19	B7-B0	I	Blue data
20-27	G7-G0	I	Green data
28-35	R7-R0	I	Red data(MSB)
36	GND	Р	Power Ground
37	DCLK	I	Clock input ;default falling edge
38	GND	Р	Power Ground
39	L/R	I	Source right or left sequence control.L/R="H"left to right; L/R="L"—right to left
40	U/D	I	gate up or down scan control. U/D="Lup to down; U/D="H"down to up
41	VGH	Р	Gate ON voltage
42	VGL	Р	Gate OFF voltage
43	AVDD	Р	Analog Power
44	RESET	I	Reset signal; suggest connect with RC circuit;low active
45	NC	1	Not connect
46	VCOM	I	For external VCOM DC input(Optional)
47	DITHB	I	Dithering setting: DITH="H" 6bit resolution (last 2 bits of input data truncated) (default setting) DITH="L" 8bit resolution
48	GND	Р	Power Ground
49-50	NC	1	Not connect



8.AC CHARACTERISTICS

 $(TA = -20 \text{ to } 85^{\circ}C, VDD = 1.71 \text{ to } 3.6V, VDDA = 6.5 \text{ to } 13.5V, VSS = VSSA = 0V)$

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
VDD Power On Slew rate	T _{POR}	From 0V to 90% VDD	-	-	20	ms
RSTB pulse width	T _{RST}	CLKIN = 50MHz	50	-	-	us
CLKIN cycle time	Tcph	-	20	-	-	ns
CLKIN pulse duty	Tcwh	-	40	50	60	1%
VSD setup time	Tvst	-	8	-	1/1 0	Jest .
VSD hold time	Tvhd	-	8	- (714 11	ns
HSD setup time	Thst	-	8	6	11 211	Me
HSD hold time	Thhd	-	8	11-11	ME	ns
Data set-up time	Tdsu	DR[7:0], DG[7:0], DB[7:0] to CLKIN	1/8	01 1	1/	M/S
Data hold time	Tdhd	DR[7:0], DG[7:0], DB[7:0] to CLKIN	1811	11-1	11-11	nd .
DEN setup time	Tesu	-	18/	1.	1-1	ns
DEN hold time	Tehd	- 21/1/1	18	1111		ns
Output stable time	Tsst	10% to 90% target voltage. CL=120pF, R=10K onto			9	us

Parallel 24-bit RGB Mode

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
CLKIN Frequency(Dual gate)	FCIR	∀ÐD = 3.3∤X	<i>))</i> -	29.2	46.5	MHz
CLKIN Cycle Time(Dual gate)	Tctk	-	22	34	-	ns
CLKIN Frequency(cascade)	Folk	VDD = 3.3V)	-	29.2	40	MHz
CLKIN Cycle Time(cascade)	Tclk <		25	34	-	ns
CLKIN Pulse Duty	Tcwh	TCIK	40	50	60	%
Time from HSD to Source Output	This)} 🗸	-	46	-	CLKIN
Time from HSD to LD	Thld	-	-	46	-	CLKIN
Time from HSD to STV	Thstv	-	-	2	-	CLKIN
Time from HSD to CKV	Thckv	-	-	20	-	CLKIN
Time from HSD to OEV	Thoev	-	-	4	-	CLKIN
LD Rulse W idth	Twld			10		CLKIN
CKV Pulse Width	Twckv	-	-	66	-	CLKIN
OEV Pulse Width	Twoev	-	-	74	-	CLKIN

II. Cascade mode

Table 18. Horizontal input timing

Parameter	Symbol	Value			Unit	Note
Horizontal display area	that	_ ((800		DCLK	
DCLK frequency	fclk	Min.	Јур.	Max		
DCLK frequency	V CIK	28.2	29.2	40	MHz	
1 Horizontal Line	tb t	908	928	1088		thb+thpw=88
HSD pulse width	thpw)) 🛂	48	87	DCLK	DCLK is
HSD Back Parch (Blanking)	thb >	87	40	1	DOLIN	fixed.
HSD Front Porch	(\ th <mark>f</mark> p	20	40	200		

Table 19. Vertical input timing

Parameter	Symbol	Min.	Тур.	Max.	Unit	Note
Vertical display area	tvd		480		Н	
VSD period time	tv	517	525	613	Н	
VSD pulse width	tvpw	1	1	3	Н	tvpw+tvb=32H Is fixed
VSD Back Porch (Blanking)	tvb	31	31	29	Н	15 lixed
VSD Front Porch	tvfp	5	13	101	Н	



Timing Waveform

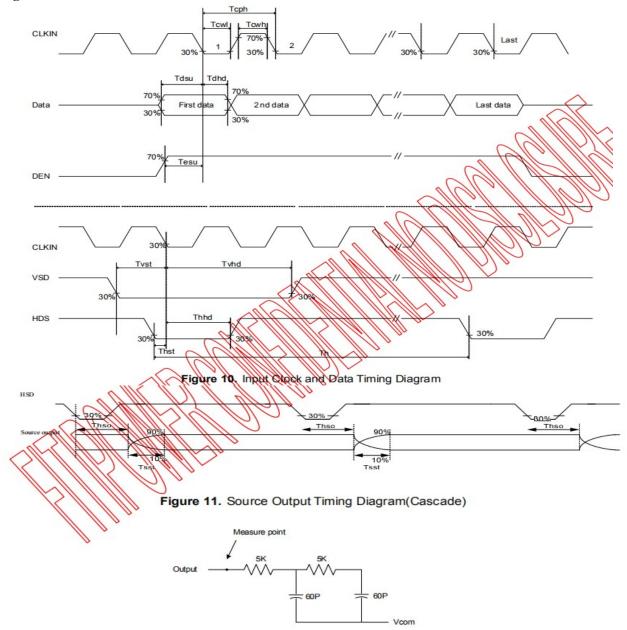


Figure 12. Output load condition

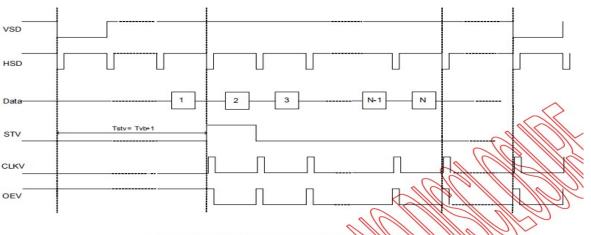


Figure 13. Vertical Timing Diagram HV Cascade)

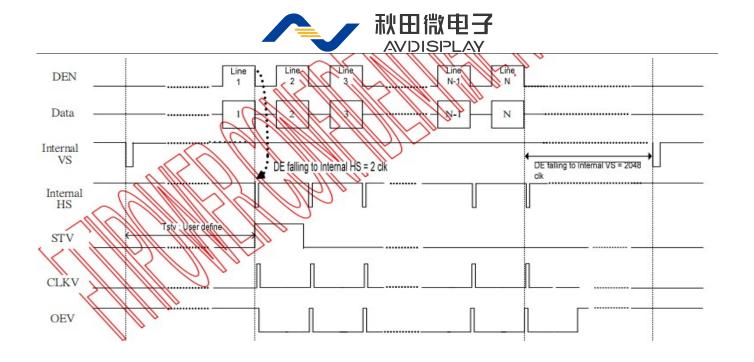


Figure 14. Vertical Timing Diagram DE (Cascade)

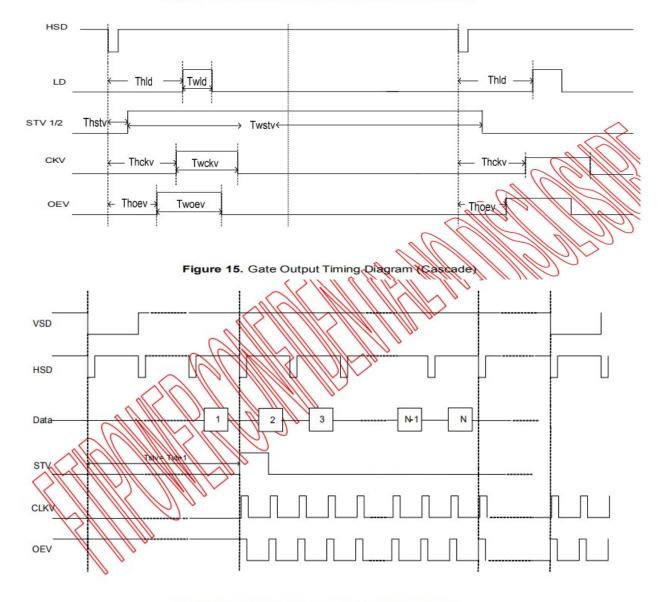
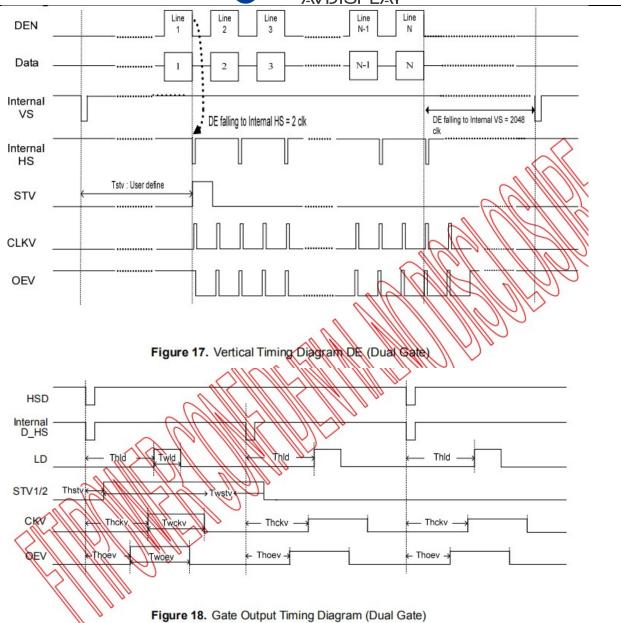


Figure 16. Vertical Timing Diagram HV (Dual Gate)







9. POWER SEQUENCE

In order to prevent IC from power on reset fail, the rising time (T_{POR}) of the digital power supply VDD should be maintained within the given specifications. Refer to "AC Characteristics" for more detail on timing.

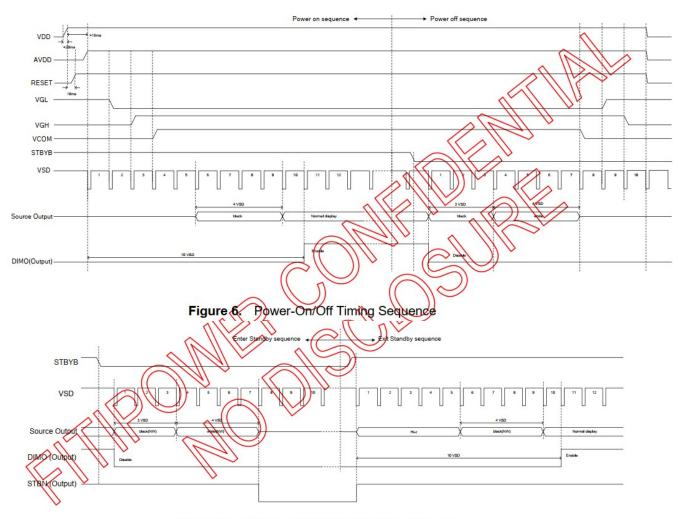


Figure 7. Enter and Exit Standby Mode Sequence



10. RELIABILITY TEST CONDITIONS

No.	Test item	Test con	Inspection after test			
11.1	High temperature storage test	+80°C/240 hours				
11.2	Low temperature storage test	-30°C/240 hours		-30°C/240 hours		
11.3	High temperature operating test	+70°C/120 hours	+70°C/120 hours			
11.4	Low temperature operating test	-20°C/120 hours		Inspection after		
11.5	Temperature cycle storage test		-30°C ~ 25°C ~ +80°C/10cycles			
11.6	High temperature high humidity test	+50°C*90% RH/120 hours		/ +50°C*90% RH/120 hours from defects		sample shall be free from defects : 1.Current changing
11.7	Vibration test	Frequency : 250 r/mi Amplitude : 1 inch Time: 45min				
		Drop direction: 1 corner/3 edges/6 sides 10 time		Non-display,abnormal-d isplay,missing lines, Short lines,ITO		
		Packing weight(kg)	Drop height(cm)	corrosion;		
11.8	Drop test	<11	80±1.6	3.Visual defect : Air bubble in the LCD,Seal		
	2.56	11≦G<21	60±1.2	leak,Glass crack.		
		21 ≤ G<31 50±1.0 31 ≤ G<40 40±0.8				
11.9	ESD test	Air discharge: ±8KV, Contact discharge: ±				

Remark:

- 1. The test samples should be applied to only one test item.
- 2.Sample size for each test item is 3~5pcs.
- 3.For High temperature high humidity test, Pure water(Resistance>10 $M\Omega$) should be used.
- 4.In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judged as a good part.
- 5.B/L evaluation should be excepted from reliability test with humidity and temperature: Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence B/L has.
- 6.Failure judgment criterion: Basic specification, Electrical characteristic, Mechanical characteristic, Optical characteristic.



11.INSPECTION CRITERION

Refer to 《Inspection Criterion for TFT Products-To customer》, DOCUMENT NO.: AVD(WI)-00-QA-048

12. HANDLING PRECAUTIONS

12.1 Mounting method

The LCD module consists of two thin glass plates with polarizes which easily be damaged. And since the module in so constructed as to be fixed by utilizing fitting holes in the printed circuit board.

Extreme care should be needed when handling the LCD modules.

12.2 Caution of LCD handling and cleaning

When cleaning the display surface, Use soft cloth with solvent [recommended below] and wipe lightly:

- .lsopropyl alcohol
- Ethyl alcohol

Do not wipe the display surface with dry or hard materials that will damage the polarizer surface.

Do not use the following solvent:

- .Water
- Aromatics

Do not wipe ITO pad area with the dry or hard materials that will damage the ITO patterns

Do not use the following solvent on the pad or prevent it from being contaminated :

- Soldering flux
- •.Chlorine (CI), Sulfur (S)

If goods were sent without being silicon coated on the pad, ITO patterns could be damaged due to the corrosion as time goes on.

If ITO corrosion happen by miss-handling or using some materials such as Chlorine (CI), Sulfur (S) from customer, Responsibility is on customer.

12.3 Caution against static charge

The LCD module use C-MOS LSI drivers, so we recommended that you:

Connect any unused input terminal to Vdd or Vss, do not input any signals before power is turned on, and ground your body, work/assembly areas, assembly equipment to protect against static electricity.

12.4 Packing

Module employ LCD elements and must be treated as such.

- .Avoid intense shock and falls from a height.
- •.To prevent modules from degradation, do not operate or store them exposed direct to sunshine or high temperature/humidity.

12.5 Caution for operation

- •.It is an indispensable condition to drive LCD's within the specified voltage limit since the higher voltage then the limit cause the shorter LCD life.
- •.An electrochemical reaction due to direct current causes LCD's undesirable deterioration, so that the use of direct current drive should be avoided.
- •.Response time will be extremely delayed at lower temperature then the operating temperature range and on the other hand at higher temperature LCD's how dark color in them. However those phenomena do not mean malfunction or out of order with LCD's, which will come back in the specified operation temperature.
- •.If the display area is pushed hard during operation, some font will be abnormally displayed but it resumes normal condition after turning off once.
- .A slight dew depositing on terminals is a cause for electro-chemical reaction resulting in terminal open circuit.
- •. Usage under the maximum operating temperature, 50%Rh or less is required.
- •. When fixed patterns are displayed for a long time, remnant image is likely to occur.

12.6 Storage

In the case of storing for a long period of time for instance, for years for the purpose or replacement use, the following ways are recommended.

- •. Storing in an ambient temperature 10°C to 30°C, and in a relative humidity of 45% to 75%. Don't expose to sunlight or fluorescent light.
- •.Storing in a polyethylene bag with the opening sealed so as not to enter fresh air outside in it . And with no desiccant.
- •.Placing in a dark place where neither exposure to direct sunlight nor light's keeping the storage temperature range.



•. Storing with no touch on polarizer surface by the anything else.

It is recommended to store them as they have been contained in the inner container at the time of delivery from us.

12.7 Safety

- •.It is recommendable to crash damaged or unnecessary LCD's into pieces and wash off liquid crystal by either of solvents such as acetone and ethanol, which should be burned up later.
- •.When any liquid leaked out of a damaged glass cell comes in contact with your hands, please wash it off well with soap and water.

13. PRECAUTION FOR USE

- **13.1** A limit sample should be provided by the both parties on an occasion when the both parties agreed its necessity. Judgment by a limit sample shall take effect after the limit sample has been established and confirmed by the both parties.
- **13.2** On the following occasions, the handing of problem should be decided through discussion and agreement between responsible of the both parties.
- •. When a question is arisen in this specification.
- •. When a new problem is arisen which is not specified in this specifications.
- •.When an inspection specifications change or operating condition change in customer is reported to AVD, and some problem is arisen in this specification due to the change.
- •. When a new problem is arisen at the customer's operating set for sample evaluation in the customer site.

14. PACKING SPECIFICATION

Please consult our technical department for detail information.

15. INITIALIZATION CODE

16. HSF COMPLIANCE

•.This products complies with ROHS 2011/65/EU and 2015/863/EU \ REACH 1907/2006/EC requirements, and the packaging complies with 94-62-EC.



Work Instruction

Inspection Criterion for TFT Products

Doc. No.	AVD (WI) -00-QA-048	Prepared by
Version	V1.1	Checked by
Pages	10	Customer approval
Effective date		Released No.
C	ontrolled Document	Keeping Properly

/	秋田微电子 AVDISPLAY	Doc. Name	Inspection Criterion for TFT Products	Ver.	V1.1
File type	Work Instruction	Doc. No.	AVD (WI) -00-QA-048	Page	Page 1 of 10

1. Objective

The TFT test criterion are set to formalize TFT quality standards for AVD with reference to those of the customer for inspection, release and acceptance of finished TFT products in order to guarantee the quality of TFT products required by the customer.

2. Scope

The criterion is applicable to all the TFT products manufactured by AVD.

3. Equipment for Inspection

Electrical tester, electrical testing machines, vernier calipers, microscopes, magnifiers, anti-static wrist straps, finger cots/gloves, labels, tri-phase cold and hot shock machine, constant temperature and humidity chamber, backlight table, ovens for high-low temperature experiments, refrigerators, constant voltage power supply (DC), desk Lamps, etc.

4. Sampling Plan and Reference Standards

4.1 Sampling plan:

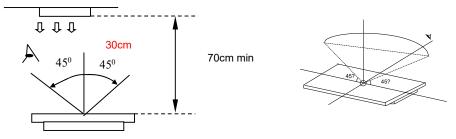
Refer to National Standard GB/T 2828.1---2012/ISO2859-1:1999, level II of normal levels:

Product Category	Non-Consumer Electronics	Industrial	Automobile
AQL	MA=0.4 MI=1.5	MA=0.25 MI=0.65	MA=0.15 MI=0.40

- 4.2 GB/T 2828.1---2012/ISO2859-1:1999 Sampling check procedure in count
- 4.3 GB/T 18910. Standard for LCM parts
- 4.4 GB/T24213-2008 Basic Environmental Test Procedures for Electrical and Electronic Products
- 4.5 IPC-A-610E Acceptability of Electronic Assemblies

5. Inspection Conditions and Inspection Reference

- 5.1Cosmetic inspection: shall be done normally at $23\pm5^{\circ}\mathbb{C}$ of the ambient temperature and $45\sim75\%$ RH of relative humidity, under the ambient luminance between 500lux ~700 lux and at the distance of 30cm apart between the inspector's eyes and the LCD panel and normally in reflected light. For backlight LCM, cosmetic inspection shall be done under the ambient luminance between 200lux ~500 lux with the backlight on.
- 5.2 The TFT shall be tested at the angle of 45°left and right and 0-45° top and bottom as the following picture showing:



5.3 Definition of viewing area (VA)

A area: Active area (AA area)

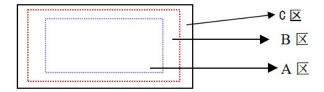
/	秋田微电子 AVDISPLAY	Doc. Name	Inspection Criterion for TFT Products	Ver.	V1.1
File type	Work Instruction	Doc. No.	AVD (WI) -00-QA-048	Page	Page 2 of 10

B area: Viewing area (VA area)

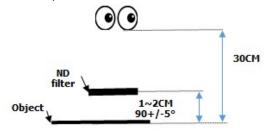
C area: Non-viewing area (not viewing after customer assembly)

If there is any appearance viewing defect which do not affect product quality and customer assembly in C area, it's accepted in generally.

The criteria apply to A and B area except chipping and crack.



- 5.4 Inspection with naked eyes(exclusive of the inspection of the physical dimensions of defects carried out with magnifiers)
- 5.5 ND card use method(refer to below image) and scope: Multi-bright dot; Mura(Black/Gray pattern uneven); dark line and so on.



5.6 Undefined items or other special items, refer to mutual agreement and limited sample. If criterion does not match product specifications/ technical requirement, both should be subject to special inspection criterion agreed by customer.

6. Defects and Acceptance Standards

- 6.1 Electrical properties test
- 6.1.1 Test voltage(V): Refer to the instruction of testers and the product specification or drawing and the display content and parameters and display effects shall conform to the product specification and drawing.
- 6.1.2 Current Consumption(I): Refer to approved product specifications or drawings.
- 6.1.3 Function items(Defect category MA)

No.	Defects	Descriptions	Pictures		Defect category
6.1.3.1	No display /reaction	shows no picture/display in normal connected situation.		Naked eyes/ testers	MA
6.1.3.2	Missing segment	Shows missing lines in normal display		Naked eyes/ testers	MA
6.1.3.3	Dark line	Only visible on gray pattern, 1 or more vertical/horizontal lines: 5%ND, not visible, OK	/	Naked eyes/ testers	MA

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6.1.3.4	POL and	gle	Not accepted		正常 POL斯反180度后	Nake tester	ed eyes/ rs	MA
6.1.3.5	Image retentior (sticking		Chess pattern and change to pattern, disapp if time>30s, NO	50% gray ear in 30s, Ok		Nake tester	d eyes/ rs	MA
6.1.3.6	Display abnorma	al	Not accepted			Nake tester	ed eyes/ rs	MA
6.1.3.7	Cross-ta	lk	Refer to AVD s	pecification	/		d eyes/ d sample	MA
6.1.3.8	Display dim/brig	ht	Refer to limited	l sample	/		d eyes/ d sample	MA
6.1.3.9	Contrast	i	Refer to limited	l sample	/		d eyes/ d sample	MA
6.1.3.10	Huge current		Out of spec, no	ot accepted	/	Amm	eter	MA
6.1.3.11	TP funct	ion	Not accepted		/	Touch	d eyes/ h/ program	MA

6.2 LCD dot/line defect

6.2.1 LCD pixel dot defect(defect category: MI)

Item	Inspection	Inspection criterion						
Size	S <5"	5≤S<10"	10≤S<15"	S≥15"				
Single bright dot(RGB dot) quantity	1	2	2	3				
2 connected bright dot quantity	0	1	1	1				
3 connected bright dot or more quantity	0	0	0	0				
Bright dot total quantity	1	2	3	4				
Single dark dot quantity	2	3	4	5				
2 connected dark dot quantity	1	1	2	2				
3 connected dark dot or more quantity	0	0	0	0				
Dark dot total quantity	3	4	5	6				
Multi-bright dot quantity	ND 5% hi	ND 5% hidden, OK						

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Item Inspection criterion

Remark: 2 bright dots distance DS≥15mm 2 dark dots distance DS≥5mm

- 1) Bright dot: Power on TFT and RGB dot in black display and size ≥ 1/2dot; or bright dot in RGB display
- 2) Dark dot: Power on TFT and gray or black dot in RGB display and size $\ge 1/2 dot$
- 3) Multi-bright dot: Power on TFT and fluorescent tiny dot in black display(only visible in black display) and single dot size<1/2dot

6.2.2 LCD appearance dot defect (defect category: MI)

		Inspectio	n criterio	on						Picture		Inspection
No.	Item	Size	S <5"	5≤S<	10"	10≤S 15"	<	S≥1	5"			method/tool s
		D≤0.15	ignore	ignore	е	D≤0	.2;	D-	·n n			
6.2.2.1		0.15< D≤0.25	3	3		Not count			D≤0.2; ignore		‡ b	Naked eyes
	Dot defect	0.25< D≤0.30	1	2		0.2~0).35	0.2	~0.35	D=(a+l		/film card /magnifier
	(black dot, white dot,	0.30< D≤0.35	0	1		Q'ty ≤	≦4	Q'ty	<i>i</i> ≤ 5			
	particle)	0.35< D≤0.50	0	0		1		2				
		D>0.5	0	0		0		0				
				≤0.15mm, not count. Multi-dot as bulk is not uantity≤ 5; 2 round dots or linear dots in 1 c					•		ıs multi-dot.	
		Length (mm)	Width (mm)	S <5"	5≤3 10"	3<	10≤9 15"	S<	S≥15"			
		Not count	W≤0.03	Ignored	lgn	ored	Igno	red	Ignore			
	Line defect	L≤5	0.03≤W <0.05	3	3		Igno	red	Ignore			Naked eyes
6.2.2.2	(visible when	L≤5	0.05≤W <0.08	0	1		3		3		-	/film card /magnifier
	power on)	L≤8	0.05≤W <0.08	0	0		1		2			
		L>8	W> 0.08	0	0		0		0			
		Remark: las watern keeping s	nark/foldii	-			•		-	•	•	st light, show efer to

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		Size(mm	S <5	5"	5≤S<10)"	10≤S< 15"	S≥15"			
	Polarizer	D≤0.20	Ignore	ed	Ignored		Ignored	Ignored		1 b	
6.2.2.3	scratch/ Dent/	0.20< D≤0.5	2		2		3	5	a		Naked eyes
	bubble defect,	0.50< D≤0.8	0		1		2	3			/film card /magnifier
particle or polarizer		0.8< D≤1.5	0		0		1	2			
		D> 1.5mm	0		0		0	0			

6.3 Chipping defect

No.	Item	Accepted	d criterion(mm)		MAJ	MIN
	ITO conductive side	Х	1	≤1/8L	1		
6.3.1	Z	Υ	Y≤1/6W	1/6W <y≤1 4w<="" td=""><td>1/4W <y< td=""><td></td><td>√</td></y<></td></y≤1>	1/4W <y< td=""><td></td><td>√</td></y<>		√
	W X	Accept	2	2	0		
6.3.2		X	× / :		1		
0.0	Corner chipping (ITO pins position)	Y	Y≤1/2W	1/2W <y≤w< td=""><td>W <y< td=""><td></td><td>√</td></y<></td></y≤w<>	W <y< td=""><td></td><td>√</td></y<>		√
		Accept	2	1	0		
	2 2 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	as per 6. into black chipping	Corner chipping occurred in sealed edge position as per 6.3.3; at the same time it should not enter into black border of the frame and the corner chipping effect the electric connection position perform as per 6.3.1.				
	Chipping in sealed	X	1	≤1/8L	1		
	area (outside chipping)	Y (outside chipping)	Not enter	Enter Y≤H	H <y< td=""><td></td><td></td></y<>		
6.3.3	Z	Y (inside chipping)	into sealant	Enter Y≤1/2H	1/2H <y< td=""><td></td><td>√</td></y<>		√
		Z	≤T	≤1/2T	1		
		Accept	2	1	0		

	/	秋田微电:	_	Doc. Name		spection Cri or TFT Proc		Ver.	V1	.1	
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	Chipping in sealed area (inside chipping)			The standards of inner and outer chipping on edge sealing area are same. When the chipping occurred in the opposite of stage, Y as per the chipping on the non-conduction side standard in 6.3.1							
	conduct	ive side	Х	1		≤1/6L	1				
	(back si	de chipping	Υ	Y	∕≤1/3W	1/3W <y≤2 3w<="" td=""><td colspan="2">2/3W <y< td=""><td></td><td>√</td></y<></td></y≤2>	2/3W <y< td=""><td></td><td>√</td></y<>			√	
6.3.4		Z		ot 2	!	2	0				
			Chipping into ITO side ,refer to 6.3.1								
	Protrudi	ng LCD	Χ	1		≤1/8L	1				
	poor cut burrs	tting and LCD	Y	≤	1/6W	1/6W <y≤1 5w<="" td=""><td>1/5W <</td><td><y< td=""><td></td><td>√</td></y<></td></y≤1>	1/5W <	<y< td=""><td></td><td>√</td></y<>		√	
6.3.5			Z	/		1	1				
			Accep	ot 1		1	1				
				•	otruding co	ntrol as per t	he tolera	ance			
			of dra								
6.3.6	Crack		crack	expand	to inside is	s without dire NG, but to o	utside is			√	
Dame	10:4) \ 10:5	one the length of				maged stand				- 41	

Remark:1)X means the length of chipping; Y means the width; Z means the thickness; W means the step width of the two glasses; H means the distance from the glass edge to the seal inner edge; t means glass thickness.

6.4 Backlight components

No.	Item	Description	Accepted criterion	MAJ	MIN
6.4.1	No backlight wrong Color	1	Rejected	√	
6.4.2	Color deviation	When powered on, the LCD color differs from its sample and found that the color not conforming to the drawing after testing.	Refer to sample and drawing.		√
6.4.3	Brightness deviation	When powered on, the LCD brightness differs from its sample and is found after testing not conforming to the drawing; or if it conforms to the drawing but the brightness over ±40% than its typical	Refer to sample and drawing.		√

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	value.									
6.4.4	Uneven brightne		the specificati	Uneven on the same LCD and out of the specification of the drawing. The no pecification evenness= (the max ralue-the min value)/ mean value<			е			V
6.4.5	Spot/line When power of		•	•	Refer to 6.2.2				√	

6.5 Metal frame (Metal Bezel)

No.	Item	Description	Accepted criterion	MAJ	MIN
6.5.1	Material & surface treatment	Metal frame/surface treatment do not conform to the specifications.	Rejected	√	
6.5.2	Tab twist Unconformity/ Tab not twisted	Wrong twist method or direction and twist tabs are not twisted as required.	Rejected	V	
6.5.3	Bezel paint loss	1.Front surface: Paint peel off and scratch to the			√
6.5.4	.5.4 Bezel scratch	bottom Dot:D≤0.5mm, exceeds 3;			√
6.5.5	Painting peel off, discoloration, dent, and scratch	Line:L≤3.0mm,W≤0.05mm exceeds 2; 2.Front dent, air bubble and side with paint peeling off scratch to the bottom Dot: D≤1.0mm, exceeds 3; Line:L≤10.0mm,W≤0.05mm, exceeds 2;	Rejected		V
6.5.6	Burr	Burr(s) on metal bezel is so long as to get into viewing area.	Rejected		1

6.6 FPC

No.	Item	Description	Accepted criterion	MAJ	MIN
6.6.1	Model & P/N	Material model & P/N	Keep the same with drawing and technical requirement	√	

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6.6.2	Dimensio position	n/	Remark f=FPC v	w H W H W H W H W H H=ITO pin le	Ī.	f≤1/3w, h ≤1/3H, dimension drawing spec-> Ok Conducive material and ITO/PDA connective a must over than 1/2. Entire dimension must spec tolerance.	d rea		√ V
6.6.3	FPC appe	earance	broken, FPC gol broken,	ssing material folding line op lden finger oxio scratch ,foreig which cause l	en; date, ın	Broken length<2mm; I line is OK- > Accepted Crack and line broken Rejected			V
6.6.4	FPC burr		Burr nea	ar FPC edge a	rea	When cover line and blength ≤1.0mm->Acce			√
6.6.5	FPC fallin	ng off		nding area fall	_	Rejected			V
6.6.6	Sealant n	nissing	Sealant ITO line	is not covered	l all	Rejected		V	
6.6.7	Missing s	ealant	No seal	ant		Rejected		$\sqrt{}$	
6.6.8	Sealant		Sealant total hei	height > produght	uct	Rejected		√	
6.6.9	FPC foldi	ng		ding as below ction is OK->A	·	Accept			√
6.6.1	FPC conr fingers dent/scra	_	dent/scr	nnecting finger ratch/ stain as nd function is cept		Accept			√

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6.7 SMT

No.	Item	Description	Accepted criterion	MAJ	MIN
6.7.1	Soldering bridge	Solder between adjacent pads and components	Rejected		√
6.7.2	Solder ball/splash	Solder ball/tin dross causing short circuit at the solder point. There are active solder ball and splash.	Rejected		V
6.7.3	Soldering excursion	Soldering slant > 1/3 soldering pad 「焊盘宽度」 「焊接宽度」	Rejected		√
6.7.4	Component wrong attaching	Component on PCB differs with drawing: wrong one, extra one, lack one, opposite polarity	Rejected	V	
	wrong addoning	JUMP short circuit on PCB: extra soldering ,lack soldering.	Rejected	√	
6.7.5	Component falling off	Soldering but component is missing	Rejected	1	
6.7.6	Wrong component	Component model/spec differs from product specification	Rejected	1	

6.8 General Appearance

No.	Item	Description	Accepted criterion	MAJ	MIN
6.8.1	Protective film scratch/bubble	Protective film scratch/bubble is OK	Accepted	V	
6.8.2	Surface stain	Defect mark or label are not removed residual glue, and finger print,etc;	Accepted		√
6.8.3	Product label	Readable even unclear or misplaced part	Accepted		V
6.8.4	Component mark	Silk screen mark clear, resistance measured value in spec	Accepted		√
6.8.5	Newton's rings	Area<1/6 screen area&quantity≤1	Accepted		V

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6.8.6	Mura	Tributation as a	ND 3% in 2.Naked 6 RGB disp	/gray display visible ->OK; eyes inspectio lay invisible blay, area<1/4	n	Accepted			√
6.8.7	Light lea	ak	by LCD la 2.Judge ii	ge(near backl imps irregular n black/white/ç ky is yellowish >NG);	illuminate gray display	Refer to limited sample Tape 浮起漏光			V
6.8.8	Polarize	er	over LCD 2.No unm in polarize	ovable stain o	or finger print	Accepted	I		V
6.8.9	TP defe	ect	TP stain(f	ogy&unremov	/able)	Accepted	I		

Remark: Anything which is not clearly defined in 6.5~6.8 should refer to IPC-A-610. Non-consumer Electronics refer to class 1 and Industrial, Automobile refer to Class 2.

7. Others

Items not specified in this document or released on compromise should be inspected with reference to mutual agreement and limit samples.